

1. Global joint venture starts operations as WeEn Semiconductors

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Thank you for your cooperation and understanding,

WeEn Semiconductors



BYV32E-200

Dual rugged ultrafast rectifier diode, 20 A, 200 V

Rev. 04 — 27 February 2009

Product data sheet

1. Product profile

1.1 General description

Ultrafast dual epitaxial rectifier diode in a SOT78 (TO-220AB) plastic package.

1.2 Features and benefits

- High reverse voltage surge capability
- High thermal cycling performance
- Low thermal resistance

- Soft recovery characteristic minimizes power consuming oscillations
- Very low on-state loss

1.3 Applications

 Output rectifiers in high-frequency switched-mode power supplies

1.4 Quick reference data

Table 1. Quick reference

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{RRM}	repetitive peak reverse voltage		-	-	200	V
I _{O(AV)}	average output current	square-wave pulse; δ = 0.5; $T_{mb} \le 115$ °C; both diodes conducting; see <u>Figure 1</u> ; see <u>Figure 2</u>	-	-	20	Α
I _{RRM}	repetitive peak reverse current	$t_p = 2 \ \mu s; \ \delta = 0.001$	-	-	0.2	Α
V_{ESD}	electrostatic discharge voltage	HBM; C = 250 pF; R = 1.5 $k\Omega$; all pins	-	-	8	kV
Dynamic	characteristics					
t _{rr}	reverse recovery time	$I_F = 1 \text{ A}$; $V_R = 30 \text{ V}$; $dI_F/dt = 100 \text{ A/}\mu\text{s}$; $T_j = 25 ^{\circ}\text{C}$; ramp recovery; see Figure 5	-	20	25	ns
		$I_R = 1 \text{ A}; I_F = 0.5 \text{ A};$ $T_j = 25 ^{\circ}\text{C}; \text{ step recovery};$ measured at reverse current = 0.25 A; see Figure 6	-	10	20	ns
Static ch	aracteristics					
V _F	forward voltage	$I_F = 8 \text{ A}$; $T_j = 150 \text{ °C}$; see Figure 4	-	0.72	0.85	V



Dual rugged ultrafast rectifier diode, 20 A, 200 V

2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	A1	anode 1		
2	K	cathode	mb	A1 + + + A2
3	A2	anode 2		<u> </u>
mb	К	mounting base; cathode	1 2 3	sym125
			SOT78 (TO-220AB;SC-46)	

3. Ordering information

Table 3. Ordering information

Type number	Package		
	Name	Description	Version
BYV32E-200	TO-220AB; SC-46	plastic single-ended package; heatsink mounted; 1 mounting hole; 3-lead TO-220AB	SOT78

Dual rugged ultrafast rectifier diode, 20 A, 200 V

4. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{RRM}	repetitive peak reverse voltage		-	200	V
V_{RWM}	crest working reverse voltage		-	200	V
V_R	reverse voltage	DC	-	200	V
I _{O(AV)}	average output current	square-wave pulse; δ = 0.5; $T_{mb} \le$ 115 °C; both diodes conducting; see Figure 1; see Figure 2	-	20	Α
I _{FRM}	repetitive peak forward current	δ = 0.5; t_p = 25 μ s; T_{mb} ≤ 115 °C; per diode	-	20	Α
I _{FSM}	non-repetitive peak forward current	t_p = 8.3 ms; sine-wave pulse; $T_{j(init)}$ = 25 °C; per diode	-	137	Α
		t_p = 10 ms; sine-wave pulse; $T_{j(init)}$ = 25 °C; per diode	-	125	Α
I _{RRM}	repetitive peak reverse current	$\delta = 0.001$; $t_p = 2 \mu s$	-	0.2	Α
I _{RSM}	non-repetitive peak reverse current	$t_p = 100 \ \mu s$	-	0.2	Α
T _{stg}	storage temperature		-40	150	°C
T _j	junction temperature		-	150	°C
V _{ESD}	electrostatic discharge voltage	HBM; C = 250 pF; R = 1.5 k Ω ; all pins	-	8	kV

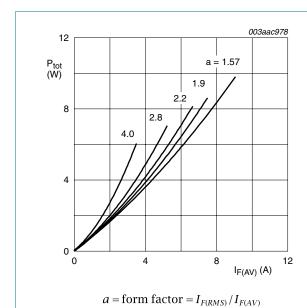


Fig 1. Forward power dissipation as a function of average forward current; sinusoidal waveform; maximum values

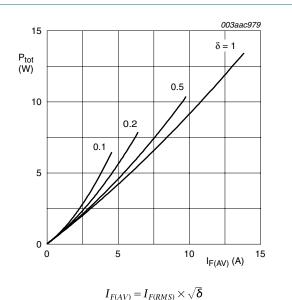


Fig 2. Forward power dissipation as a function of average forward current; square waveform; maximum values

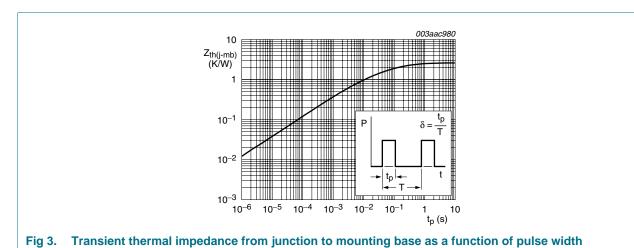
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5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-mb)}$	thermal resistance from junction to mounting	with heatsink compound; both diodes conducting	-	-	1.6	K/W
	base	with heatsink compound; per diode; see Figure 3	-	-	2.4	K/W
$R_{th(j-a)}$	thermal resistance from junction to ambient		-	60	-	K/W

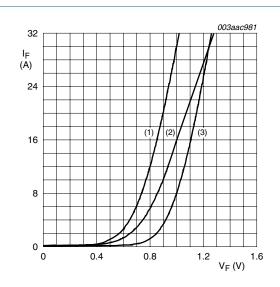


6. Characteristics

Table 6. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
V_{F}	forward voltage	I _F = 20 A; T _j = 25 °C	-	1	1.15	V
		I _F = 8 A; T _j = 150 °C; see <u>Figure 4</u>	-	0.72	0.85	V
I _R	reverse current	$V_R = 200 \text{ V}; T_j = 100 \text{ °C}$	-	0.2	0.6	mA
		V _R = 200 V; T _j = 25 °C	-	6	30	μΑ
Dynamic	characteristics					
Q _r	recovered charge	$I_F = 2 \text{ A}$; $V_R = 30 \text{ V}$; $dI_F/dt = 20 \text{ A/}\mu\text{s}$; $T_j = 25 \text{ °C}$	-	8	12.5	nC
t _{rr}	reverse recovery time	$I_F = 1 \text{ A}$; $V_R = 30 \text{ V}$; $dI_F/dt = 100 \text{ A/}\mu\text{s}$; ramp recovery; $T_j = 25 \text{ °C}$; see Figure 5	-	20	25	ns
		$I_F = 0.5 \text{ A}$; $I_R = 1 \text{ A}$; step recovery; measured at reverse current = 0.25 A; $T_j = 25 ^{\circ}\text{C}$; see Figure 6	-	10	20	ns
V_{FR}	forward recovery voltage	$I_F = 1 \text{ A}$; $dI_F/dt = 10 \text{ A/}\mu\text{s}$; $T_j = 25 \text{ °C}$; see Figure 7	-	-	1	V

Dual rugged ultrafast rectifier diode, 20 A, 200 V



- (1) $T_j = 150$ °C; typical values
- (2) $T_j = 150$ °C; maximum values
- (3) $T_j = 25$ °C; maximum values

Fig 4. Forward current as a function of forward voltage

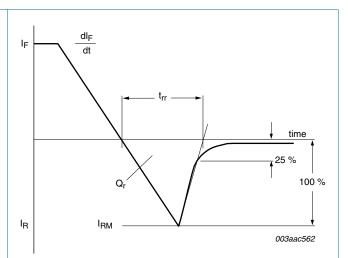


Fig 5. Reverse recovery definitions; ramp recovery

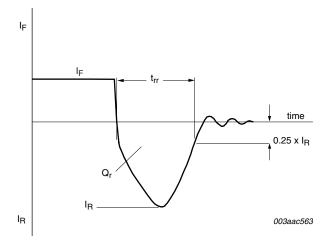


Fig 6. Reverse recovery definitions; step recovery

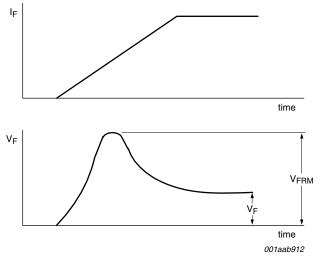
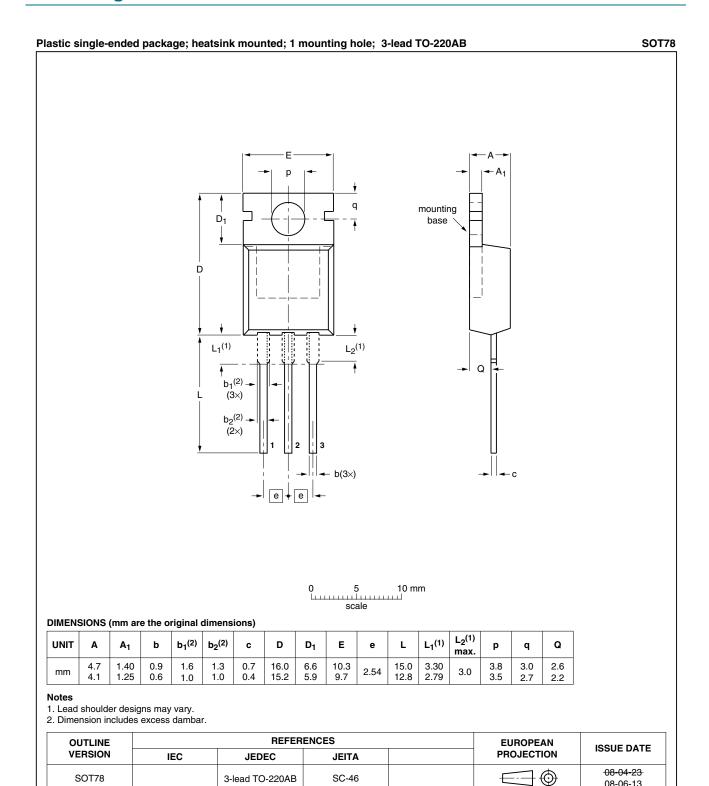


Fig 7. Forward recovery definitions

Dual rugged ultrafast rectifier diode, 20 A, 200 V

Package outline



Package outline SOT78 (TO-220AB)

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08-06-13

Dual rugged ultrafast rectifier diode, 20 A, 200 V

8. Revision history

Table 7. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes			
BYV32E-200_4	20090227	Product data sheet	-	BYV32E_SERIES_3			
Modifications:	 The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors. Legal texts have been adapted to the new company name where appropriate. 						
	Package outline updated.						
	Type number	er BYV32E-200 separated	from data sheet BYV32	2E_SERIES_3			
BYV32E_SERIES_3	20010301	Product specification	-	BYV32E_SERIES_2			
BYV32E_SERIES_2	19980701	Product specification	-	BYV32EB_SERIES_1			
BYV32EB SERIES 1	19960801	Product specification	_	_			

Dual rugged ultrafast rectifier diode, 20 A, 200 V

9. Legal information

9.1 Data sheet status

Document status [1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
- [3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com.

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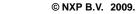
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Dual rugged ultrafast rectifier diode, 20 A, 200 V

11. Contents

1	Product profile	!
1.1	General description	1
1.2	Features and benefits	1
1.3	Applications	1
1.4	Quick reference data	1
2	Pinning information	2
3	Ordering information	2
4	Limiting values	3
5	Thermal characteristics	4
6	Characteristics	4
7	Package outline	6
8	Revision history	7
9	Legal information	8
9.1	Data sheet status	8
9.2	Definitions	8
9.3	Disclaimers	8
9.4	Trademarks	8
10	Contact information	Q

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